

Notice of References Cited	Application/Control No. 10/539,804	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Jay M. Patidar	Art Unit 2862	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,382,900 A	01-1995	Hayashi, Yasukazu	324/207.23
*	B	US-5,696,444 A	12-1997	Kipp et al.	324/207.23
*	C	US-2005/0121987 A1	06-2005	Ritzinger et al.	310/068.00B
*	D	US-7,157,906 B2	01-2007	Miya, Taiichi	324/207.25
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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